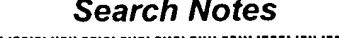


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/555,078	YIP ET AL.
	Examiner	Art Unit
	Ann Y. Lam	1641

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner